## **FETKY<sup>™</sup>** Power MOSFET and Schottky Diode

# -20 V, -3.3 A P-Channel with 20 V, 1.0 A Schottky Diode, Micro8<sup>™</sup> Package

The FETKY product family incorporates low  $R_{DS(on)}$ , true logic level MOSFETs packaged with industry leading, low forward drop, low leakage Schottky Barrier Diodes to offer high efficiency components in a space saving configuration. Independent pinouts for TMOS and Schottky die allow the flexibility to use a single component for switching and rectification functions in a wide variety of applications.

#### Features

- Low V<sub>F</sub> and Low Leakage Schottky Diode
- Lower Component Placement and Inventory Costs along with Board Space Savings
- Logic Level Gate Drive Can be Driven by Logic ICs
- Pb–Free Package is Available

#### Applications

- Buck Converter
- Synchronous Rectification
- Low Voltage Motor Control
- Load Management in Battery Packs, Chargers, Cell Phones, and other Portable Products

#### **MOSFET MAXIMUM RATINGS** (T<sub>A</sub> = 25°C unless otherwise noted)

Rating Symbol Value Unit						
Rat	Symbol	Value	Unit			
Drain-to-Source Voltage			V <sub>DSS</sub>	-20	V	
Gate-to-Source Volta	ge		V <sub>GS</sub>	±10	V	
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	-3.3	А	
Current (Note 1)		T <sub>A</sub> = 100°C		-2.1		
Power Dissipation (Note 1)	Steady State	$T_A = 25^{\circ}C$	PD	1.42	W	
Continuous Drain	T <sub>A</sub> = 25°C		I <sub>D</sub>	-2.4	А	
Current (Note 2)	T <sub>A</sub> = 100°C			-1.5		
Power Dissipation (Note 2)	Steady State	$T_A = 25^{\circ}C$	PD	0.78	W	
Pulsed Drain Current	t = 10 μs		I <sub>DM</sub>	-10	A	
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C	
Single Pulse Drain–to–Source Avalanche Energy Starting $T_A$ = 25°C (t $\leq$ 10 s)			EAS	150	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surface-mounted on FR4 board using 1 in sq pad size

(Cu area = 1.127 in sq [1 oz] including traces).

 Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.172 in sq).



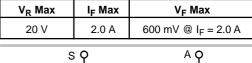
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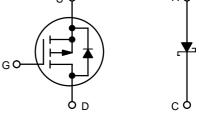
#### http://onsemi.com

#### MOSFET PRODUCT SUMMARY

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> Typ	I <sub>D</sub> Max
–20 V	70 mΩ @ –4.5 V	–3.3 A
	100 mΩ @ –2.7 V	–2.7 A

#### SCHOTTKY DIODE SUMMARY

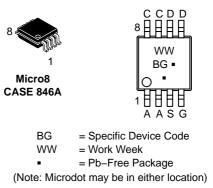




P-Channel MOSFET

#### Schottky Diode





#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTTD4401FR2	Micro8	4000/Tape & Reel
NTTD4401FR2G	Micro8 (Pb–Free)	4000/Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### SCHOTTKY DIODE MAXIMUM RATINGS ( $T_A = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Reverse Voltage	V	20	V
Average Forward Current (Rated $V_R$ , $T_A = 100^{\circ}C$ )	۱ <sub>0</sub>	1.0	A
Peak Repetitive Forward Current (Note 3)	I <sub>FRM</sub>	2.0	A
Non-Repetitive Peak Surge Current (Note 4)	I <sub>FSM</sub>	20	A

#### THERMAL RESISTANCE RATINGS

		FET	Schottky	
Rating	Symbol	Мах		Unit
Junction-to-Ambient - Steady State (Note 5)	$R_{ hetaJA}$	88	135	°C/W
Junction-to-Ambient - Steady State (Note 6)	$R_{ hetaJA}$	160	250	°C/W

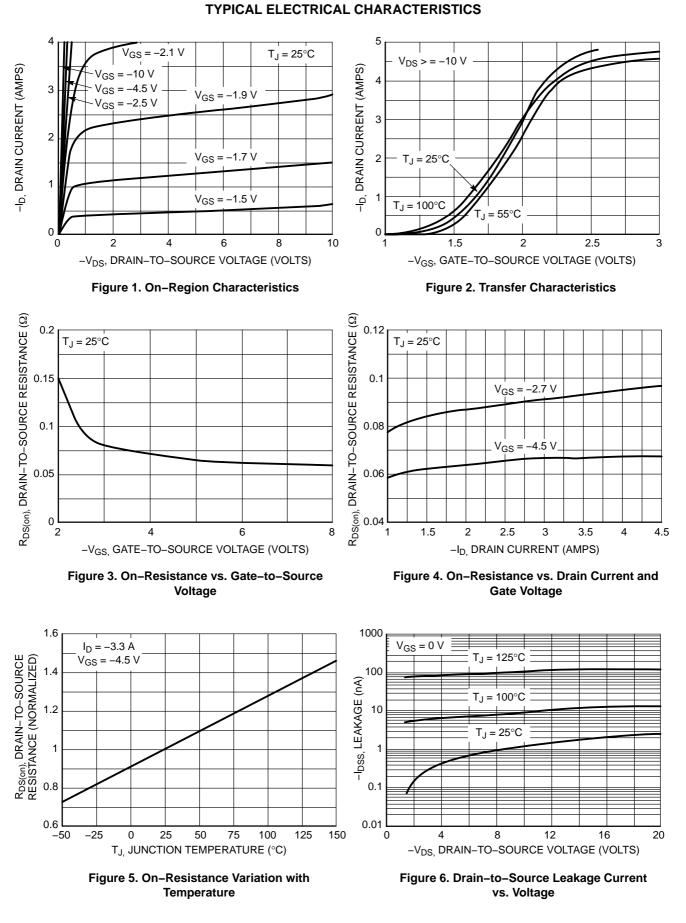
### **MOSFET ELECTRICAL CHARACTERISTICS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit	
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V	-20	-	_	V	
Zero Gate Voltage Drain Current (Note 7)	I <sub>DSS</sub>	$V_{GS} = 0 V, V_{DS} = -16 V$	_	-	-1.0	μΑ	
		$V_{GS} = 0 \text{ V}, \text{ T}_{\text{J}} = 125^{\circ}\text{C}, \text{ V}_{\text{DS}} = -16 \text{ V}$	-	-	-25		
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 10 V$	_	-	±100	nA	
ON CHARACTERISTICS							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = -250 \ \mu A$	-0.5	-	-1.5	V	
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>	_	-	2.5	-	mV/°C	
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = -4.5 V, I <sub>D</sub> = -3.3 A	_	70	90	mΩ	
		$V_{GS} = -2.5 \text{ V}, \text{ I}_{D} = -1.2 \text{ A}$	_	100	150		
Forward Transconductance	<b>9</b> FS	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -2.7 \text{ A}$	_	4.2	_	S	
CHARGES, CAPACITANCES AND GATE	RESISTANCE				-		
Input Capacitance	CISS		-	550	750	pF	
Output Capacitance	C <sub>OSS</sub>	$V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = -16 V$	_	200	300		
Reverse Transfer Capacitance	C <sub>RSS</sub>		_	50	175		
Total Gate Charge	Q <sub>G(TOT)</sub>		_	10	18	nC	
Gate-to-Source Gate Charge	Q <sub>GS</sub>	$V_{GS} = -4.5 \text{ V}, V_{DS} = -16 \text{ V},$ $I_{D} = -3.3 \text{ A}$	_	1.5	3.0	-	
Gate-to-Drain "Miller" Charge	Q <sub>GD</sub>		_	5.0	10		
SWITCHING CHARACTERISTICS					-		
Turn–On Delay Time	t <sub>d(ON)</sub>		_	11	20	ns	
Rise Time	t <sub>r</sub>	$V_{GS} = -4.5 \text{ V}$ . $V_{DD} = -10 \text{ V}$ .	_	35	65		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = -4.5 \text{ V}, V_{DD} = -10 \text{ V},$ $I_{D} = -3.3 \text{ A}, R_{G} = 6.0 \Omega$	_	33	60		
Fall Time	t <sub>f</sub>		_	29	55		
DRAIN-SOURCE DIODE CHARACTERIS	TICS				-		
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = 0 V, I_{S} = -2.0 A$	-	-0.88	-1.0	V	
Reverse Recovery Time	t <sub>RR</sub>		-	37	50	ns	
Charge Time	ta	$V_{GS} = 0 V$ , $d_{IS}/dt = 100 A/\mu s$ , $I_{S} = -3.3 A$	-	16	_		
Discharge Time	t <sub>b</sub>	.5 - 0.071	-	21	_		
Reverse Recovery Charge	Q <sub>RR</sub>	_	_	0.025	0.05	nC	

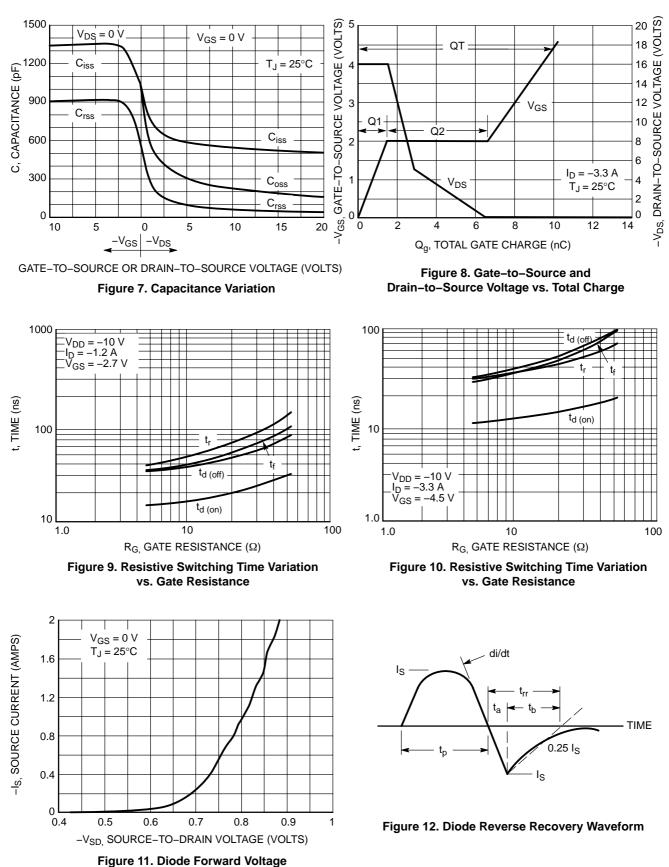
Rated V<sub>R</sub>, square wave, 20 kHz, T<sub>A</sub> = 105°C.
 Surge applied at rated load conditions, half-wave, single phase, 60 Hz.
 Surface-mounted on FR4 board using 1 inch sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
 Surface-mounted on FR4 board using the minimum recommended pad size (Cu area = 0.172 in sq).
 Body diode leakage current.

### SCHOTTKY DIODE ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = $25^{\circ}$ C unless otherwise noted)

Characteristic	Symbol	Test Condition I <sub>R</sub> = 1.0 mA		Min	Тур	Max	Unit
Reverse Breakdown Voltage	B <sub>V</sub>			20	-	-	V
Reverse Leakage Current	۱ <sub>R</sub>	N 00 M	$T_A = 25^{\circ}C$	-	-	0.05	mA
		V <sub>R</sub> = 20 V	T <sub>A</sub> = 125°C	-	-	10	1
Forward Voltage	V <sub>F</sub>		$T_A = 25^{\circ}C$	-	-	0.5	V
		I <sub>F</sub> = 1.0 A	T <sub>A</sub> = 125°C	-	-	0.39	
		1 004	$T_A = 25^{\circ}C$	-	-	0.6	
		I <sub>F</sub> = 2.0 A	T <sub>A</sub> = 125°C	-	-	0.53	1
Voltage Rate of Change	dV/dt	V <sub>R</sub> = 2	D V	-	10,000	-	V/μs







vs. Current

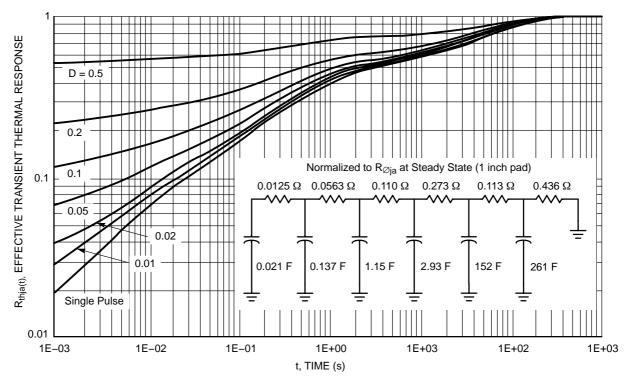
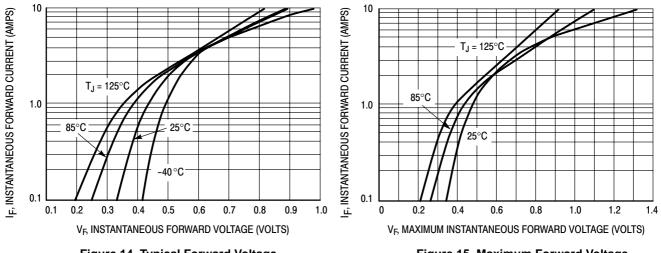


Figure 13. FET Thermal Response

### TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS



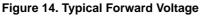
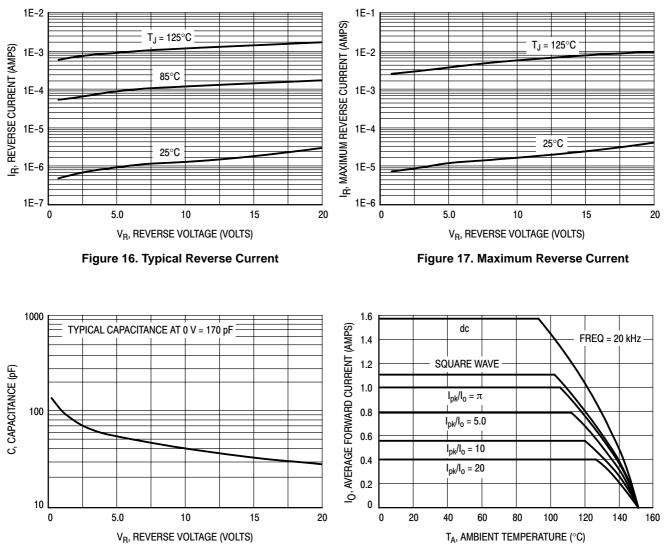


Figure 15. Maximum Forward Voltage



#### TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

Figure 18. Typical Capacitance

Figure 19. Current Derating

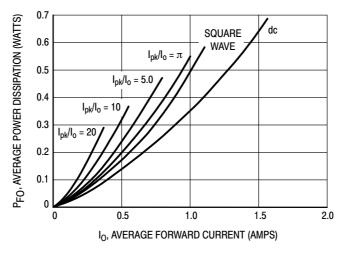


Figure 20. Forward Power Dissipation

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